

ST2054

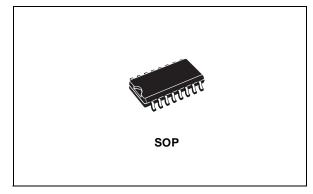
CURRENT LIMITED POWER DISTRIBUTION SWITCHES

- 80mΩ HIGH-SIDE MOSFET SWITCH
- 500mA CONTINUOUS CURRENT PER CHANNEL
- INDEPENDENT THERMAL AND SHORT-CIRCUIT PROTECTION WITH OVERCURRENT LOGIC OUTPUT
- OPERATING RANGE FROM 2.7V TO 5.5V
- CMOS- AND TTL-COMPATIBLE ENABLE INPUTS
- 10 ms OC_N FAULT BLANKING
- 2.5ms TYPICAL RISE TIME
- UNDERVOLTAGE LOCKOUT
- 20µA MAXIMUM STANDBY SUPPLY CURRENT
- AMBIENT TEMPERATURE RANGE, 0°C TO 85°C
- ESD PROTECTION

DESCRIPTION

The ST2054 power distribution switches is intended for application where heavy capacitive loads and short circuits are likely to be encountered. These devices incorporate $80m\Omega$ N-channel MOSFET high-side power switches for power-distribution systems that require multiple powers switches in a single package. Each switch is controlled by an independent logic enable input. Gate drive is provided by an internal charge pump designed to control the power-switch rise times and fall times to minimize current surges during switching. The charge pump requires no external

Table 1: Order Codes



components and allows operation from supplies as low as 2.7 V.

When the output load exceeds the current-limit threshold or a short is present, these devices limit the output current to a safe level by switching into a constant-current mode, pulling the overcurrent (\overline{OCx}) logic output low. A 10ms deglitching circuit provides fault-blanking feature, preventing the OC_N pin to be asserted during hot-insertion or short spikes of overcurrent conditions.

When continuous heavy overloads and short circuits increase the power dissipation in the switch, causing the junction temperature to rise, a thermal protection circuit shuts off the switch to prevent damage. Recovery from a thermal shutdown is automatic once the device has cooled sufficiently. Internal circuitry ensures the switch remains off until valid input voltage is present. These power-distribution switches are designed to current limit at 0.9 A.

Туре	Temperature Range	Package	Comments
ST2054BD	-40 to 85 °C	SO-16 (Tube)	50parts per tube / 40tube per box
ST2054BDR	-40 to 85 °C	SO-16 (Tape & Reel)	2500 parts per reel

Figure 1: Pin Configuration

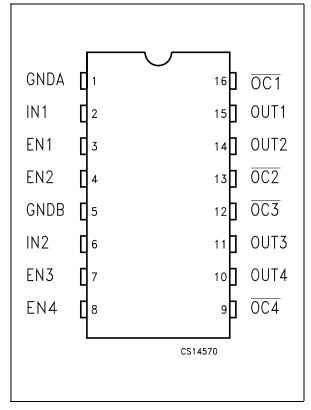


Table 2: Pin Description

PIn N°	Symbol	Name And Function
1	GNDA	Ground
2	IN1	Input Voltage
3	EN1	Enable Input. Logic High Turns On Power Switch IN-OUT1
4	EN2	Enable Input. Logic High Turns On Power Switch IN-OUT2
5	GNDB	Ground
6	IN2	Input Voltage
7	EN3	Enable Input. Logic High Turns On Power Switch IN-OUT3
8	EN4	Enable Input. Logic High Turns On Power Switch IN-OUT4
9	OC4	Overcurrent. Logic Output Active Low IN-OUT4
10	OUT4	Power Switch Output
11	OUT3	Power Switch Output
12	OC3	Overcurrent. Logic Output Active Low IN-OUT3
13	OC2	Overcurrent. Logic Output Active Low IN-OUT2
14	OUT2	Power Switch Output
15	OUT1	Power Switch Output
16	OC1	Overcurrent. Logic Output Active Low IN-OUT1

Table 3: Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
VI	Input Voltage Range (Note 1)	-0.3 to 6	V
Vo	Output Voltage Range (Note 1)	-0.3 to (V _I +0.3)	V
V _{IENX}	Input Voltage Range	-0.3 to 6	V
Ι _Ο	Continuous Output Current	Internally Limited	
ESD	Electrostatic Discharge	2	kV
Τ _J	Operating Junction Temperature	-40 to 125	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these condition is not implied. Note1: All voltage are referred to GND

Table 4: Recommended Operating Condition

Symbol	Parameter	Min.	Тур.	Max.	Unit
VI	Input Voltage Range (Note 1)	2.7		5.5	V
Vo	Output Voltage Range (Note 1)	0		5.5	V
Ι _Ο	Continuous Output Current (Per Switch)	0		500	mA

Figure 2: Block Diagram

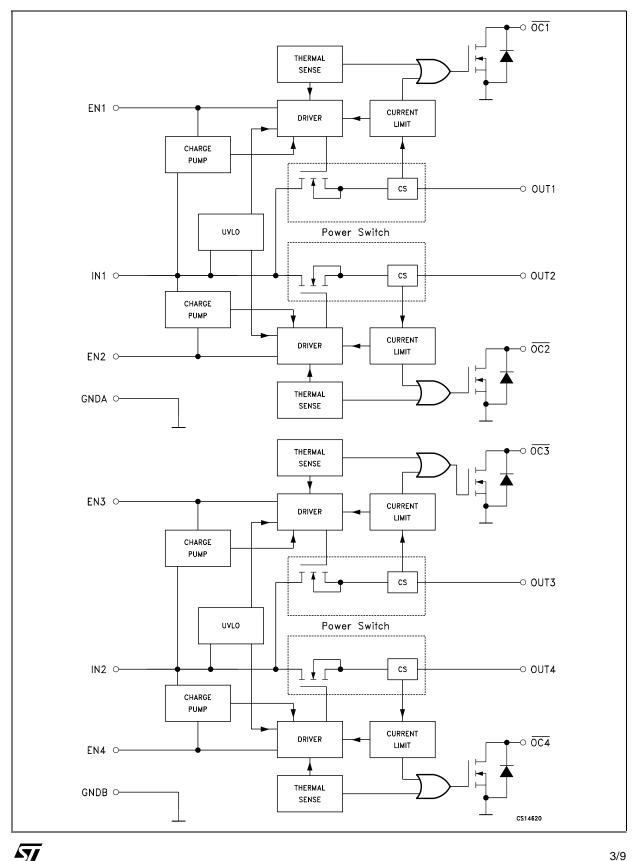


Table 5: Power Switch Electrical Characteristics ($V_I = 5.5V$, $I_O = rated current$, $V_{IEN} = V_I$, $T_J = 25^{\circ}C$,
unless otherwise specified.) (See Note 1)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
R _{DS(ON)}	Static Drain-Source	V _I =5V I _O = 0.5A		80	100	mΩ
	ON-State Resistance	V _I =5V I _O = 0.5AT _J =85°C		90	120	
		V _I =5V I _O = 0.5AT _J =125°C		100	135	
		V _I =3.3V I _O = 0.5A		90	125	
		V _I =3.3V I _O = 0.5AT _J =85°C		110	145	
		V _I =3.3V I _O = 0.5AT _J =125°C		120	160	
t _r	Output Rise Time	$V_{I} = 5.5V R_{L} = 10\Omega C_{L} = 1\mu F$		2.5		ms
		$V_{I} = 2.7V R_{L} = 10\Omega C_{L} = 1\mu F$		3		
t _f	Output Fall Time	$V_{I} = 5.5V R_{L} = 10\Omega C_{L} = 1\mu F$		0.3		ms
		$V_{I} = 2.7V R_{L} = 10\Omega C_{L} = 1\mu F$		0.2		

Table 6: Enable Input ENx Characteristics ($V_I = 5.5V$, $I_O =$ rated current, $V_{IEN} = V_I$, $T_J = 25^{\circ}C$, unless otherwise specified.) (See Note 1)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{IH}	High level Input Voltage	V _I =2.7V to 5.5V	2			V
VIL	Low level Input Voltage	V _I =4.5V to 5.5V			0.8	V
		V _I =2.7V to 4.5V			0.4	
l _l	Input Current	V _{IENX} = V _I or 0V	-0.5		0.5	μA
t _{on}	Turn-on Time	$R_L=10\Omega$ $C_L=100\mu F$			20	ms
t _{off}	Turn-off Time	$R_L=10\Omega$ $C_L=100\mu F$			40	ms

Table 7: Current Limit Characteristics ($V_I = 5.5V$, $I_O =$ rated current, $V_{IEN} = V_I$, $T_J = 25^{\circ}C$, unless otherwise specified.) (See Note 1)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{OS}	Short Circuit Output Current	V _I =5V, OUT connected to GND, device enabled into short circuit	0.7	1	1.3	A

Table 8: Supply Current Characteristics ($V_I = 5.5V$, $I_O = rated current$, $V_{IEN} = V_I$, $T_J = 25$ °C, unless otherwise specified.) (See Note 1)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{SOL}	Current Low Level Output	V _{IENX} = 0, No Load,		0.05	2	μΑ
		$V_{IENX} = 0$, No Load, $T_{J}=-40$ to $125^{\circ}C$			20	
I _{SOH}	Current Low High Output	V _{IENX} = V _I , No Load,		140	180	μΑ
		$V_{IENX} = V_I$, No Load, T_J =-40 to 125°C			200	
١L	Output Leakage Current	V _{IENX} = 0, Output Connected to GND, T _J =-40 to 125°C			20	μA

Table 9: Undervoltage Characteristics ($V_I = 5.5V$, $I_O = rated current$, $V_{IEN} = V_I$, $T_J = 25$ °C, unless otherwise specified.) (See Note 1)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{IL}	Low Level Input Voltage		2		2.5	V
V _{HYS}	Hysteresys			100		mV

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Table 10: Overcurrent (\overline{OC}) Characteristics (V_I = 5.5V, I_O = rated current, V_{IEN} =V_I, T_J = 25°C, unless otherwise specified.) (See Note 1)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{SINK}	Sink Current	V _O =5V	10			mA
Vo	Output Low Voltage	I _O =5mA			0.5	V
I _{OFF}	OFF-State Current	V _O =5V V _O =3.3V			1	μA
T _{FB}	Fault-Blanking period	V_{I} =5.5V, T_{J} =25°C (See Note 2 and 3)	2	10		ms

Note 1: Pulse testing techniques maintain junction temperature close to ambient temperature: thermal effect must be takes into account sep-Note 2: Specified by design, not production tested. Note 3: Guaranteed by design.

Figure 3: Test Circuit

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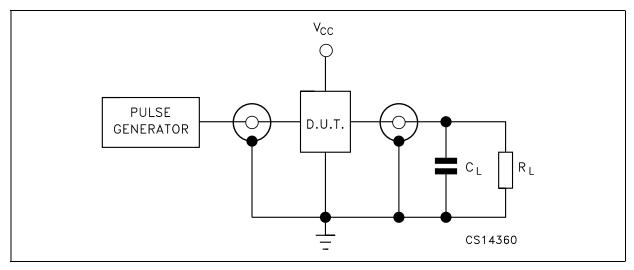
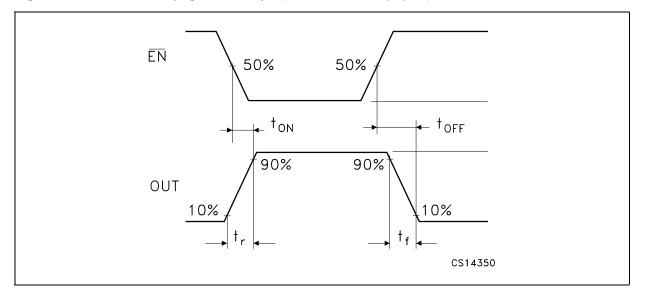
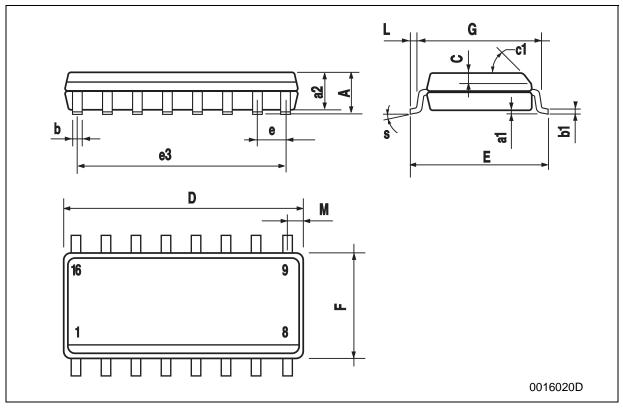


Figure 4: Waveform - Propagation Delays (f=1MHz; 50% duty cycle)



SO-16 MECHANICAL DATA

DIM	mm.			inch			
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.	
А			1.75			0.068	
a1	0.1		0.25	0.004		0.010	
a2			1.64			0.063	
b	0.35		0.46	0.013		0.018	
b1	0.19		0.25	0.007		0.010	
С		0.5			0.019		
c1		•	45°	(typ.)	*		
D	9.8		10	0.385		0.393	
Е	5.8		6.2	0.228		0.244	
е		1.27			0.050		
e3		8.89			0.350		
F	3.8		4.0	0.149		0.157	
G	4.6		5.3	0.181		0.208	
L	0.5		1.27	0.019		0.050	
М			0.62			0.024	
S		•	8° (r	max.)			



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Tape & Reel SO-16 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А			330			12.992
С	12.8		13.2	0.504		0.519
D	20.2			0.795		
Ν	60			2.362		
Т			22.4			0.882
Ao	6.45		6.65	0.254		0.262
Во	10.3		10.5	0.406		0.414
Ko	2.1		2.3	0.082		0.090
Po	3.9		4.1	0.153		0.161
Р	7.9		8.1	0.311		0.319

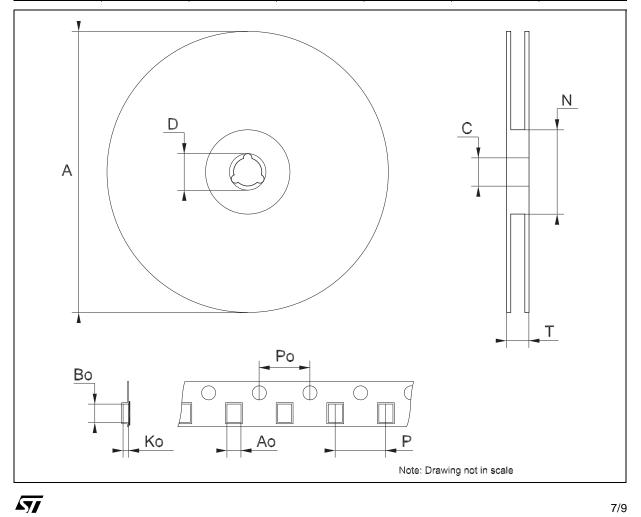


Table 11: Revision History

Date	Revision	Description of Changes
28-Oct-2004	2	Maturity Change.
13-Jul-2005	3	Add bullet on pag. 1, add paragraph in the description on pag. 1 and add row $T_{\mbox{FB}}$ on Table 10.

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